

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10590565	PAREEK ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
HENG M CHAN	1795	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
424	474, 475, 480, 481, 482	11/25/2009	HMC
106	163.01, 172.1, 178.1,	11/25/2009	HMC
UPDATED		5/29/2010	HMC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST: USPAT, US-PGPUB, USOCR, JPO, EPO, FPRS, DERWENT, IBM-TDB	11/24/2009	HMC
Inventors searched in Palm	11/24/2009	HMC
Consulted Jerry Lorengo about 112 2nd issues	11/24/2009	HMC
Assignee searched in EAST	11/25/2009	HMC
UPDATED	5/28	HMC
Consulted Nikki Dees about areas of search	5/24	HMC
Consulted Jennifer Michener about claim 1	6/1	HMC
Consulted Carlos Barcena about claim 6	6/3	HMC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>